


<b>Search Notes</b> 	<b>Application/Control No.</b> 09122740	<b>Applicant(s)/Patent Under Reexamination</b> TOMIZAWA, KAZUHIRO
	<b>Examiner</b> FLEURANTIN, JEAN B	<b>Art Unit</b> 2162

SEARCHED			
Class	Subclass	Date	Examiner
707	1-10, 100-10.1 & 200-206	7/16/2007	JBF
709	212, 213, 215 & 216	7/16/2007	JBF
711	108, 154, 200, 205 & 207	7/16/2007	JBF
718	100	7/16/2007	JBF

SEARCH NOTES			
Search Notes		Date	Examiner
WEST (US PG PUB, US PT, EPO, JPO, DERWENT & IBM TDB).		7/16/2007	JBF
707/ccls & 711/ccls & Inventors Search & all related applications have been reviewed.		7/16/2007	JBF
NPL - ACM & IEEE		7/16/2007	JBF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
707	101 & 200	7/16/2007	JBF
711	154	7/16/2007	JBF
718	100	7/16/2007	JBF